

**Notice of References Cited**

Application/Control No.  
10/646,808

Applicant(s)/Patent Under  
Reexamination  
HAN ET AL.

Examiner  
ALEX NOGUEROLA

Art Unit  
1753

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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*Alex Noguerola*

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